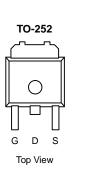
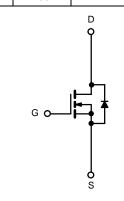


2SK4090-ZK-VB Datasheet N-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^{a, e}	Q _g (Typ)		
30	0.002 at V _{GS} = 10 V	100	72 nC		
50	0.003 at V _{GS} = 4.5 V	90	72110		





N-Channel MOSFET

FEATURES

- ٠ Trench Power MOSFET
- 100 % R_g and UIS Tested
- Compliant to RoHS Directive 2011/65/EU •

APPLICATIONS

- OR-ing
- Server
- DC/DC

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	30	V		
Gate-Source Voltage		V _{GS}	± 20	V	
	T _C = 25 °C		100 ^{a, e}	A	
Continuous Drain Current (T _J = 175 °C)	T _C = 70 °C		80 ^e		
$Continuous Drain Current (1_j = 175 C)$	T _A = 25 °C	I _D	35.8 ^{b, c}		
	T _A = 70 °C		27 ^{b, c}		
Pulsed Drain Current	I _{DM}	300			
Avalanche Current Pulse	L = 0.1 mH	I _{AS}	39		
Single Pulse Avalanche Energy	L = 0.1 mm	E _{AS}	94.8	mJ	
Continuous Source-Drain Diode Current	T _C = 25 °C		90 ^{a, e}	^	
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	3.13 ^{b, c}	— A	
	T _C = 25 °C		235 ^a		
	T _C = 70 °C	P	165	w	
Maximum Power Dissipation	T _A = 25 °C	P _D	3.75 ^{b, c}		
	T _A = 70 °C		2.63 ^{b, c}		
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 175	°C		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Тур.	Max.	Unit	
Maximum Junction-to-Ambient ^{b, d}	$t \le 10 \text{ sec}$	R _{thJA}	32	40	°C/W	
Maximum Junction-to-Case	Steady State	R _{thJC}	0.5	0.6	0/10	

Notes:

a. Based on $T_C = 25 \text{ °C}$. b. Surface mounted on 1" x 1" FR4 board.

a. t = 10 sec.
d. Maximum under steady state conditions is 90 °C/W.
e. Calculated based on maximum junction temperature. Package limitation current is 90 A.



SPECIFICATIONS ($T_J = 25 \ ^{\circ}C$,		Test Conditions	Min	Turn	Max	Unit
Parameter Static	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA	30			V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	VGS = 0 4, 1D = 200 p. (50	35		v
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 7.5		mV/°C
Gate-Source Threshold Voltage		V _{DS} = V _{GS} , I _D = 250 µA	1.5	- 7.5	2.5	V
5	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 200 \mu X$ $V_{DS} = 0 V, V_{GS} = \pm 20 V$	1.5		-	-
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$ $V_{DS} = 30 V, V_{GS} = 0 V$			± 100	nA μA
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 \text{ °C}$			1	
On-State Drain Current ^a		$v_{DS} = 30 \text{ v}, v_{GS} = 0 \text{ v}, r_{J} = 55 \text{ C}$ $V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	90		10	۸
	I _{D(on)}	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 38.8 \text{ A}$	90	0.002		A
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 37 \text{ A}$				Ω
Forward Transconductors	0.	$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 37 \text{ A}$ $V_{DS} = 15 \text{ V}, \text{ I}_{D} = 38.8 \text{ A}$		0.003		S
Forward Transconductance ^a	9 _{fs}	$v_{\rm DS} = 13 v, i_{\rm D} = 30.0 {\rm A}$		160		3
Dynamic ^b		[5001		T
Input Capacitance	C _{iss}			5201		pF
Output Capacitance	C _{oss}	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz		1525		
Reverse Transfer Capacitance	C _{rss}			770		
Total Gate Charge	Qg	$V_{DS} = 15 \text{ V}, \text{ V}_{GS} = 10 \text{ V}, \text{ I}_{D} = 38.8 \text{ A}$		151	227	
Cata Causa Obarra	-			71.5	103	
Gate-Source Charge	Q _{gs}	$V_{DS} = 15 \text{ V}, \text{ V}_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 28.8 \text{ A}$		30		
Gate-Drain Charge	Q _{gd}	(, , , , , , , , , , , , , , , , , , ,		24		
Gate Resistance	Rg	f = 1 MHz		1.4	2.1	Ω
Turn-On Delay Time	t _{d(on)}			18	27	-
Rise Time	t _r	$V_{DD} = 15 \text{ V}, \text{ R}_{L} = 0.625 \Omega$		11	17	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 24 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		70	105	
Fall Time	t _f			10	15	ns
Turn-On Delay Time	t _{d(on)}			55	83	-
Rise Time	t _r	$V_{DD} = 15 \text{ V}, \text{ R}_{\text{L}} = 0.67 \Omega$		180	270	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 22.5 \text{ A}, \text{ V}_{\text{GEN}} = 4.5 \text{ V}, \text{ R}_{\text{g}} = 1 \Omega$		55	83	
Fall Time	t _f			12	18	
Drain-Source Body Diode Characteristic	s		[1	
Continuous Source-Drain Diode Current	۱ _S	T _C = 25 °C			120	A
Pulse Diode Forward Current ^a	I _{SM}				120	
Body Diode Voltage	V_{SD}	I _S = 22 A		0.8	1.2	V
Body Diode Reverse Recovery Time	t _{rr}			52	78	ns
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 20 A, di/dt = 100 A/μs, T _J = 25 °C		70.2	105	nC
Reverse Recovery Fall Time	t _a	$r_{\rm r} = 2000, {\rm d}_{\rm r} {\rm d}_{\rm r} = 10000 {\rm d}_{\rm r} {\rm d}_{\rm r}, r_{\rm J} = 2000$		27		ns
Reverse Recovery Rise Time	t _b	t _b		25		115

Notes:

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.

b. Guaranteed by design, not subject to production testing.

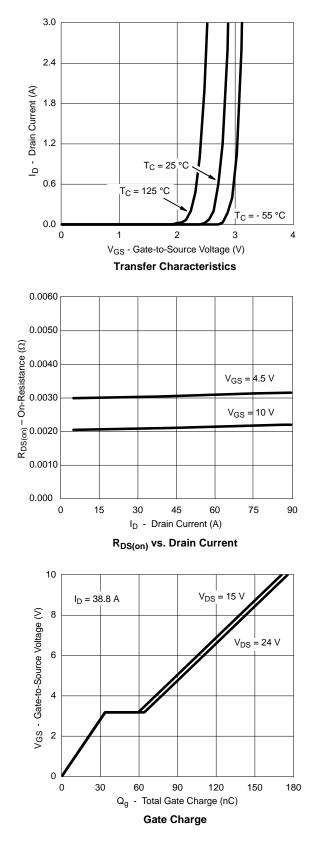
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Bsemi



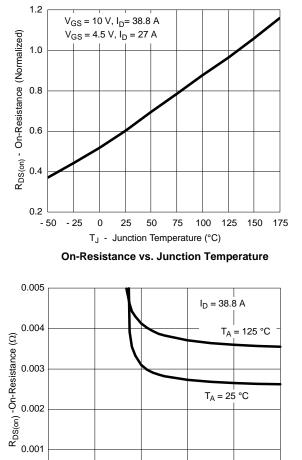
90 V_{GS} = 10 V thru 4 V 75 60 I_D - Drain Current (A) 45 30 15 $V_{IGS} = 2 V$ $V_{GS} = 3 V$ 0 2.0 2.5 0.0 0.5 1.0 1.5 V_{DS} - Drain-to-Source Voltage (V) **Output Characteristics** 600 T_C = 25 °C 500 G_{fs} - Transconductance (S) T_C = 125 °C 400 300 T_C = - 55 °C 200 100 0 10 20 30 70 80 90 0 40 50 60 I_{D} Drain Current (A) -Transconductance 8000 Ciss 6000 C - Capacitance (pF) 4000 2000 Coss 1000 Crss 0 0 6 12 18 24 30 V_{DS} - Drain-to-Source Voltage (V) Capacitance

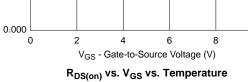
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

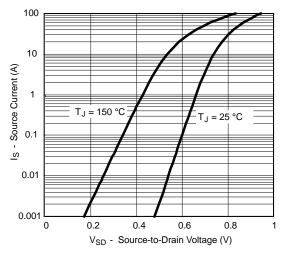




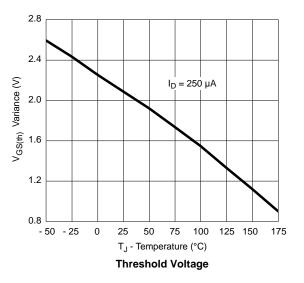
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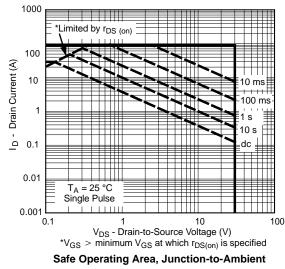






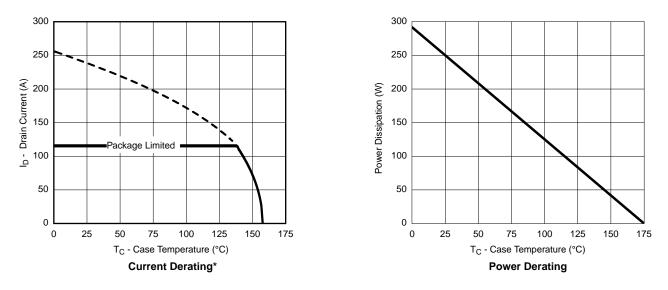
Forward Diode Voltage vs. Temperature





10





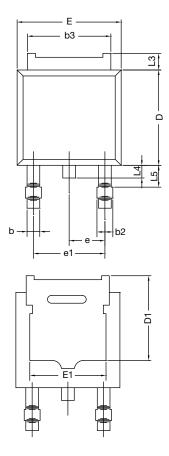
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

*The power dissipation P_D is based on $T_{J(max)} = 175$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





TO-252AA CASE OUTLINE





	MILLIMETERS		INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
А	2.18	2.38	0.086	0.094	
A1	-	0.127	-	0.005	
b	0.64	0.88	0.025	0.035	
b2	0.76	1.14	0.030	0.045	
b3	4.95	5.46	0.195	0.215	
С	0.46	0.61	0.018	0.024	
C2	0.46	0.89	0.018	0.035	
D	5.97	6.22	0.235	0.245	
D1	5.21	-	0.205	-	
Е	6.35	6.73	0.250	0.265	
E1	4.32	-	0.170	-	
Н	9.40	10.41	0.370	0.410	
е	2.28 BSC		0.090 BSC		
e1	4.56	4.56 BSC		0.180 BSC	
L	1.40	1.78	0.055	0.070	
L3	0.89	1.27	0.035	0.050	
L4	-	1.02	-	0.040	
L5	1.14	1.52	0.045	0.060	
ECN: X12- DWG: 534	0247-Rev. M, 7	24-Dec-12			

Note

• Dimension L3 is for reference only.



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